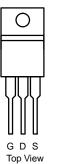
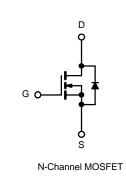


# N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ)		
30	0.0030 at V <sub>GS</sub> = 10 V	98	82 nC		
	0.0040 at V <sub>GS</sub> = 4.5 V	90			

#### TO-220AB





#### **FEATURES**

- **DT-Trench Power MOSFET** ٠
- 100 % R<sub>g</sub> and UIS Tested
  Compliant to RoHS Directive 2011/65/EU

#### **APPLICATIONS**

- OR-ing ٠
- Server
- DC/DC

Parameter		Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	30	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		98 <sup>a, e</sup>	
Continuous Drain Current (T $= 175$ °C)	T <sub>C</sub> = 70 °C		98 <sup>e</sup>	
Continuous Drain Current (T <sub>J</sub> = 175 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	28.8 <sup>b, c</sup>	Α
	T <sub>A</sub> = 70 °C		27 <sup>b, c</sup>	A
Pulsed Drain Current		I <sub>DM</sub>	294	
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	36	
Single Pulse Avalanche Energy		E <sub>AS</sub>	263	mJ
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	L.	90 <sup>a, e</sup>	Α
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	3.13 <sup>b, c</sup>	A
	T <sub>C</sub> = 25 °C		250 <sup>a</sup>	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	175	10/
	T <sub>A</sub> = 25 °C	۲D	3.75 <sup>b, c</sup>	- W
	T <sub>A</sub> = 70 °C		2.63 <sup>b, c</sup>	
Operating Junction and Storage Temperature Ra	ange	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	$t \le 10 \text{ sec}$	R <sub>thJA</sub>	32	40	°C/W	
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	0.5	0.6	0/10	

Notes:

a. Based on  $T_C = 25 \text{ °C}$ . b. Surface mounted on 1" x 1" FR4 board.

b. Surface mounted on the control board.
c. t = 10 sec.
d. Maximum under steady state conditions is 90 °C/W.
e. Calculated based on maximum junction temperature. Package limitation current is 90 A.



# DTP0403

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<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static	1		1			1		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	30			V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		35		mV/°C		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 7.5				
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1.5		2.5	V		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ± 20 V			± 100	nA		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA		
		$V_{DS}$ = 30 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C			10			
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	90			A		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 28.8 A		0.0030	0.0038			
		$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 27 \text{ A}$		0.0040	0.0044	Ω		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 28.8 A		160		S		
Dynamic <sup>b</sup>				•	•			
Input Capacitance	C <sub>iss</sub>			12065		pF		
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = 15 V, $V_{GS}$ = 0 V, f = 1 MHz		1725				
Reverse Transfer Capacitance	C <sub>rss</sub>			970				
Total Gate Charge	Qg	$V_{DS}$ = 15 V, $V_{GS}$ = 10 V, $I_{D}$ = 28.8 A		171	257	nC		
				81.5	123			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = 15 V, $V_{GS}$ = 4.5 V, $I_{D}$ = 28.8 A		34				
Gate-Drain Charge	Q <sub>gd</sub>			29				
Gate Resistance	Rg	f = 1 MHz		1.4	2.1	Ω		
Turn-On Delay Time	t <sub>d(on)</sub>			18	27	ns		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, R <sub>L</sub> = 0.625 $\Omega$		11	17			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 24$ A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		70	105			
Fall Time	t <sub>f</sub>			10	15			
Turn-On Delay Time	t <sub>d(on)</sub>			55	83			
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_{L}$ = 0.67 $\Omega$		180	270			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 22.5 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		55	83			
Fall Time	t <sub>f</sub>	-		12	18			
Drain-Source Body Diode Characteristic	-		I	I		1		
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			90			
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				294	A		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 22 A		0.8	1.2	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			52	78	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			70.2	105	nC		
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = 20 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		27		- ns		
Reverse Recovery Rise Time	t <sub>b</sub>			25				

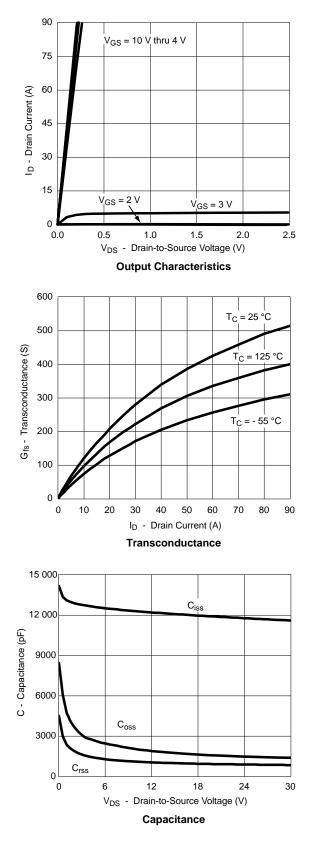
Notes:

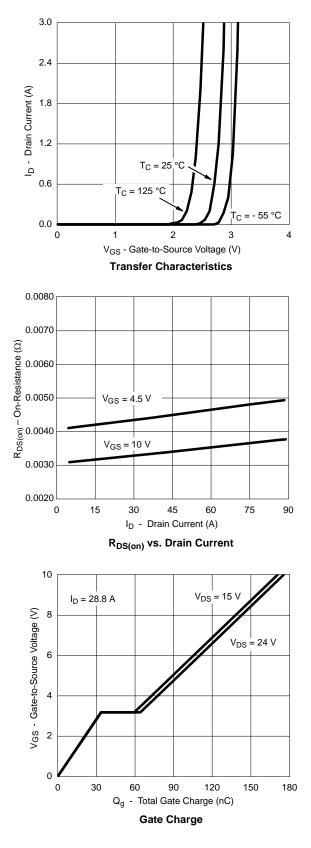
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

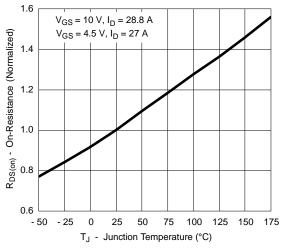
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

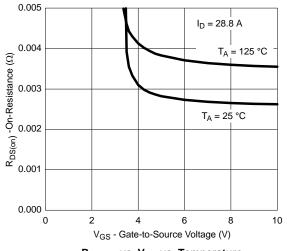


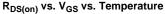


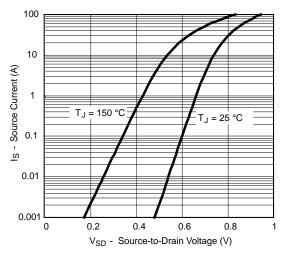
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



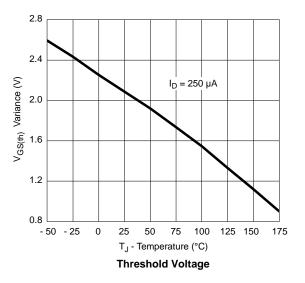
**On-Resistance vs. Junction Temperature** 

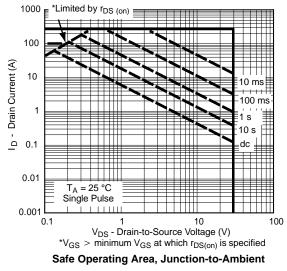




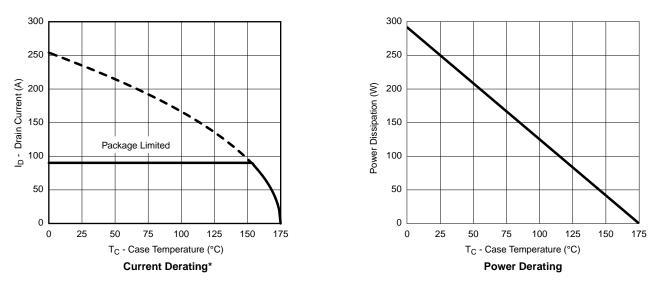


Forward Diode Voltage vs. Temperature

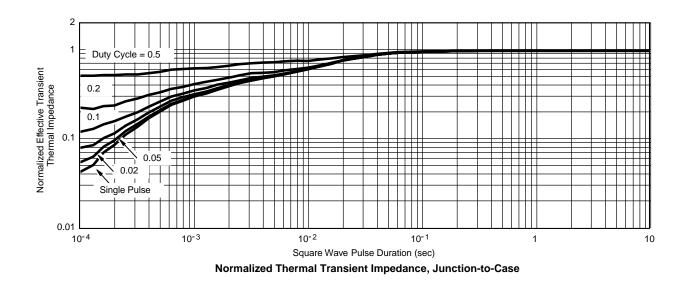




### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



\*The power dissipation  $P_D$  is based on  $T_{J(max)} = 175$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





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Please note that some Din-Tek documentation may still make reference to RoHS Directive 2002/95/EC. We confirm that all the products identified as being compliant to Directive 2002/95/EC conform to Directive 2011/65/EU.

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